

Reverse Conducting IGBT with monolithic body diode Features:

- Powerful monolithic Body Diode with very low forward voltage •
- Body diode clamps negative voltages •
- Trench and Fieldstop technology for 1200 V applications offers : •

 - very tight parameter distribution
 high ruggedness, temperature stable behavior
- NPT technology offers easy parallel switching capability due to • positive temperature coefficient in V_{CE(sat)}
- Low EMI •
- Qualified according to JEDEC¹ for target applications •
- Pb-free lead plating; RoHS compliant •
- Complete product spectrum and PSpice Models : http://www.infineon.com/igbt/ ٠

Applications:

- Inductive Cooking
- Soft Switching Applications •

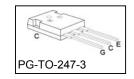
Туре	V _{CE}	l _c	V _{CE(sat), Tj=25°C}	T j,max	Marking	Package
IHW25N120R2	1200V	25A	1.6V	175°C	H25R1202	PG-TO-247-3

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	1200	V
DC collector current $T_{\rm C} = 25^{\circ}{\rm C}$ $T_{\rm C} = 100^{\circ}{\rm C}$	I _C	50 25	A
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	75	
Turn off safe operating area ($V_{CE} \le 1200V, T_j \le 175^{\circ}C$)	-	75	
Diode forward current	I _F		
$T_{\rm C} = 25^{\circ}{\rm C}$		50	
$T_{\rm C}$ = 100°C		25	
Diode pulsed current, t_p limited by T_{jmax}	I _{Fpuls}	75	
Diode surge non repetitive current, t_p limited by T_{jmax} $T_C = 25^{\circ}C$, $t_p = 10ms$, sine halfwave $T_C = 25^{\circ}C$, $t_p \le 2.5\mu s$, sine halfwave $T_C = 100^{\circ}C$, $t_p \le 2.5\mu s$, sine halfwave	I _{FSM}	50 130 120	
Gate-emitter voltage	V _{GE}	±20	V
Transient Gate-emitter voltage ($t_p < 10 \ \mu$ s, D < 0.01)		±25	
Power dissipation $T_{\rm C}$ = 25°C	P _{tot}	365	W
Operating junction temperature	Tj	-40+175	°C
Storage temperature	T _{stg}	-55+175	
Soldering temperature, 1.6mm (0.063 in.) from case for 10s	-	260	



IHW25N120R2



¹ J-STD-020 and JESD-022

Power Semiconductors



Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit	
Characteristic				•	
IGBT thermal resistance,	R _{thJC}		0.41	K/W	
junction – case					
Diode thermal resistance,	R _{thJCD}		0.41		
junction – case					
Thermal resistance,	R _{thJA}		40		
junction – ambient					

Electrical Characteristic, at T_i = 25 °C, unless otherwise specified

Parameter	Symphol	Conditions	Value			Unit
Parameter	Symbol		min.	Тур.	max.	Unit
Static Characteristic						
Collector-emitter breakdown voltage	V _{(BR)CES}	$V_{\rm GE}$ =0V, $I_{\rm C}$ =500 μ A	1200	-	-	V
Collector-emitter saturation voltage	V _{CE(sat)}	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =25A				
		<i>T</i> _j =25°C	-	1.6	1.8	
		<i>T</i> _j =150°C	-	1.95	-	
		<i>T</i> _j =175°C	-	2.0	-	
Diode forward voltage	V _F	V _{GE} =0V, <i>I</i> _F =25A				
		<i>T</i> _j =25°C	-	1.5	1.75	
		<i>T</i> _j =150°C	-	1.75	-	
		<i>T</i> _j =175°C	-	1.8	-	
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I _C =0.58mA, V _{CE} =V _{GE}	5.1	5.8	6.4	
Zero gate voltage collector current	ICES	V _{CE} =1200V, V _{GE} =0V				μA
		<i>T</i> _j =25°C	-	-	4	
		<i>T</i> _j =175°C	-	-	2500	
Gate-emitter leakage current	I _{GES}	$V_{\rm CE} = 0 V, V_{\rm GE} = 20 V$	-	-	100	nA
Transconductance	g _{fs}	V _{CE} =20V, <i>I</i> _C =25A	-	16.3	-	S
Integrated gate resistor	R _{Gint}			none		Ω



Dynamic Characteristic

Input capacitance	Ciss	V _{CE} =25V,	-	2342	-	pF
Output capacitance	Coss	V _{GE} =0V,	-	68.7	-	
Reverse transfer capacitance	Crss	f=1MHz	-	55.5	-	
Gate charge	Q _{Gate}	V _{CC} =960V, <i>I</i> _C =25A V _{GE} =15V	-	60.7	-	nC
Internal emitter inductance measured 5mm (0.197 in.) from case	L _E		-	13	-	nH

Switching Characteristic, Inductive Load, at T_j =25 °C

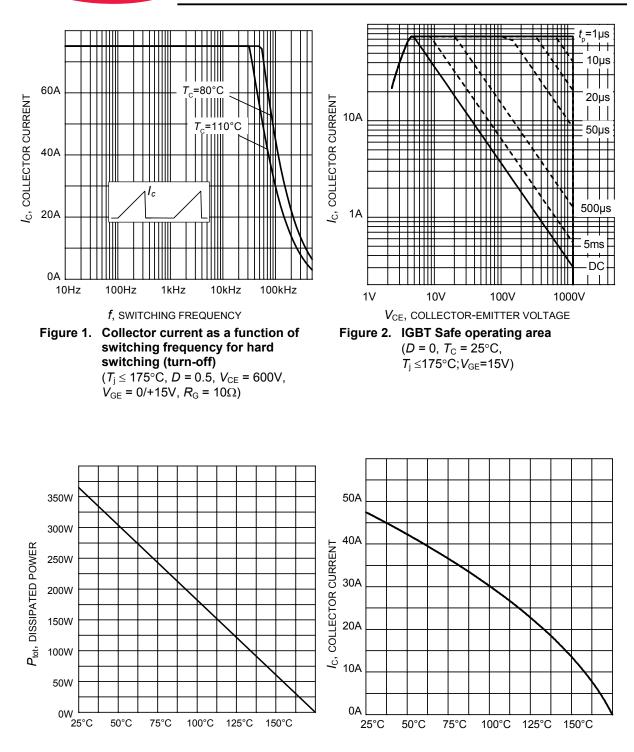
Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
IGBT Characteristic						
Turn-off delay time	$t_{d(off)}$	<i>T</i> _j =25°C, <i>V</i> _{CC} =600V, <i>I</i> _C =25A	-	324	-	ns
Fall time	tf	$V_{\rm GC}$ =600V, $I_{\rm C}$ =25A $V_{\rm GE}$ =0 /15V, $R_{\rm G}$ =10 Ω ,	-	55.8	-	
Turn-on energy	Eon		-	-	-	
Turn-off energy	E _{off}		-	1.59	-	
Total switching energy	Ets		-	1.59	-	mJ

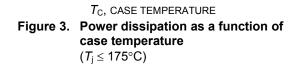
Switching Characteristic, Inductive Load, at Tj=175 °C

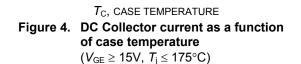
Parameter	Symbol	Conditions	Value			Unit
	Symbol		min.	Тур.	max.	
IGBT Characteristic						
Turn-off delay time	$t_{d(off)}$	<i>T</i> _j =175°C	-	373	-	ns
Fall time	t _f	V_{CC} =600V, I_{C} =25A, V_{GE} = 0 /15V, R_{G} = 10 Ω ,	-	90.6	-	
Turn-on energy	Eon		-	-	-	
Turn-off energy	E _{off}	,	-	2.54	-	
Total switching energy	E _{ts}		-	2.54	-	mJ



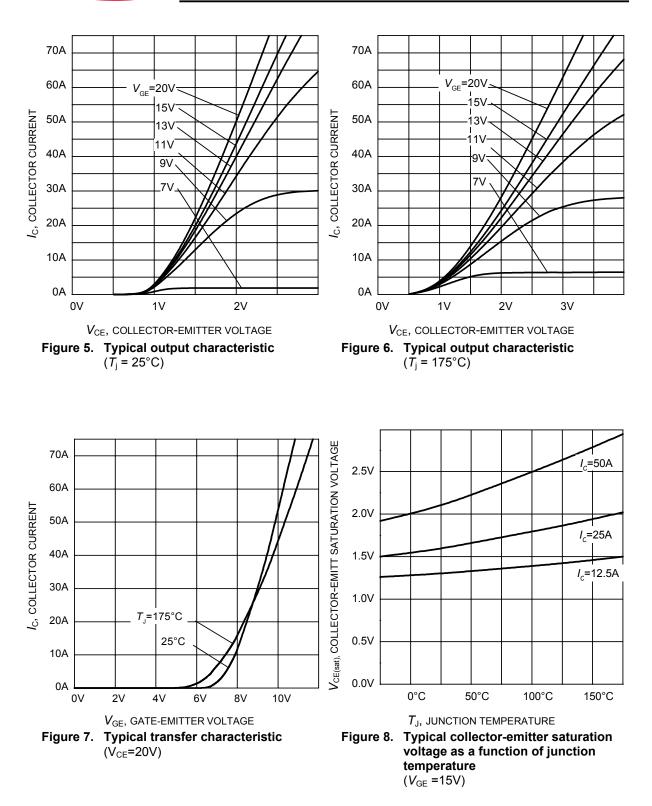
Soft Switching Series







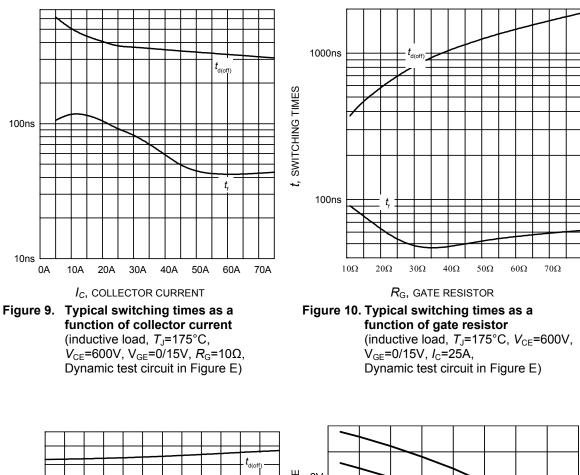


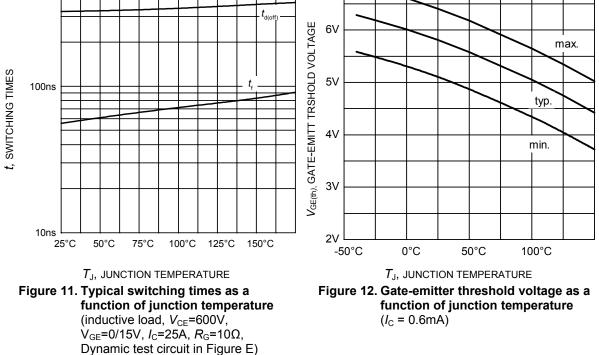




t, SWITCHING TIMES

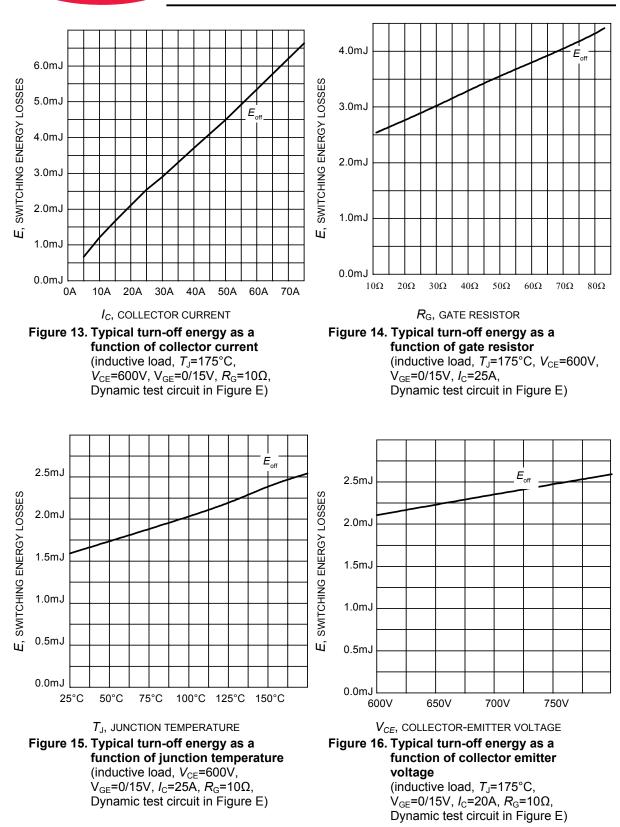
Soft Switching Series







Soft Switching Series





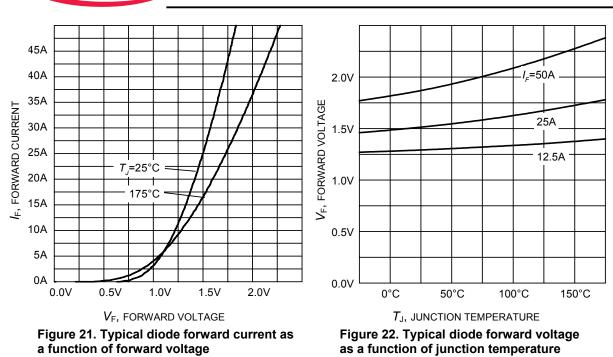
C_{iss} 15V V_{GE}, GATE-EMITTER VOLTAGE 240V 1nF 960V C, CAPACITANCE 10V 5V 100pF C С 0١ 0nC 25nC 50nC 75nC 10V 20V 0V Q_{GE} , GATE CHARGE V_{CE} , COLLECTOR-EMITTER VOLTAGE Figure 18. Typical capacitance as a function Figure 17. Typical gate charge (I_C=25 A) of collector-emitter voltage $(V_{GE}=0V, f=1 \text{ MHz})$ 0.5 Z_{thJC}, TRANSIENT THERMAL RESISTANCE Z_{thJC}, TRANSIENT THERMAL RESISTANCE 10⁻¹K/W $R_{(K/W)}$ (s) τ. 0 0 0 7 9 7.66*10 0.1708 1.24*10 R,(K/W)τ. (s) 0.1263 8.56*10 0.0183 6.66*10 0.035 7.52*10 2.85*10⁻² 0.1313 10⁻²K/W 0.1358 5.49*10 0.1257 4.51*10 $C_1 =$ τ_1/R_1 $C_2 = \tau_2/R$ inale pulse С $C_2 = \tau_2 / R_2$ 10⁻³K/W 10µs 10ms 100ms 10µs 100µs 1ms 10ms 100ms 100µs 1ms $t_{\rm P}$, PULSE WIDTH

 $t_{\rm P}$, PULSE WIDTH Figure 19. IGBT transient thermal resistance $(D = t_{\rm p} / T)$

Figure 20. Diode transient thermal impedance as a function of pulse width $(D=t_{\rm P}/T)$



Soft Switching Series

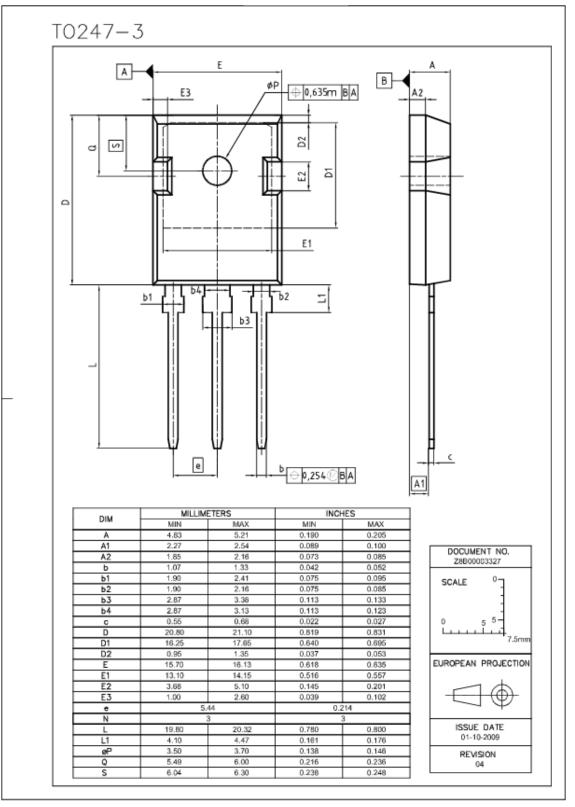




Soft Switching Series

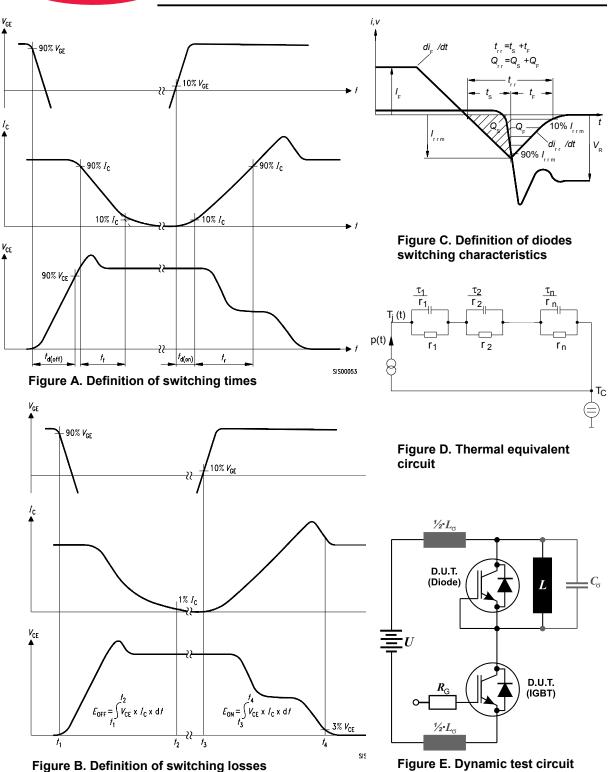
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Soft Switching Series





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